

# Electronic Information Disclosure Statement

## METHOD FOR PREPARING SUBMICRON PARTICLE SUSPENSIONS



Application:   
10/021692

Confirmation: 9772

Applicant(s): James Kipp

Docket Number: IFT-5657A-2

Group Art Unit: 1615

Examiner:

search string: ( 5560933 or 5552160 or 5543133 or 5534270 or 5518738 or 5510118 or 5494683 or 5470583 or 5447710 or 5429824 or 5399363 or 5389263 or 5352459 or 5346702 or 5340564 or 5336507 or 5326552 or 5302401 or 5298262 or 5250236 or 5246707 or 5188837 or 5152923 or 5145684 or 5133908 or 5100591 or 5091188 or 5091187 or 5078994 or 5023271 or 4973465 or 4798846 or 4725442 or 4622219 or 4540602 or 4452817 or 4073943 or 4056635 ).pn.

### US Patent Documents

Note: Applicant is not required to submit a paper copy of cited US Patent Documents

init	Citation No.	Patent Number	Date	Bar Code	Patentee	Class	Subclass
PO1	5560933	1996-10-01		Soon-Shiong et al.	424	489	
PO2	5552160	1996-09-03		Liversidge et al.	424	489	
PO3	5543133	1996-08-06		Swanson et al.	424	9.45	
PO4	5534270	1996-07-09		De Castro	424	490	
PO5		1996-05-21		Eickhoff et al.	424	493	

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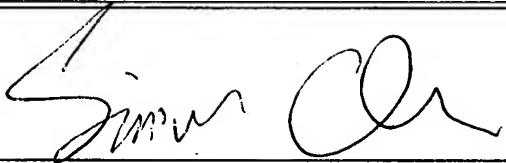
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	P09	5447710	1995-09-05		Na et al.	424	9455
	P10	5429824	1995-07-04		June	424	489
	P11	5399363	1995-03-21		Liversidge et al.	424	489
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	P13	5352459	1994-10-04		Hollister et al.	424	489
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	P16	5336507	1994-08-09		Na et al.	424	489
	P17	5326552	1994-07-05		Na et al.	424	4
	P18	5302401	1994-04-12		Liversidge et al.	424	501
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	P20	5250236	1993-10-05		Gasco	264	4.4
	P21	5246707	1993-09-21		Haynes	424	450
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	P24	5145684	1992-09-08		Liversidge et al.	424	489
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	P35	4540602	1985-09-10	██████████	Motoyama et al.	427	213.31
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## Signature

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search string: 6090925 or 6086376 or 6068858 or 6063910 or 6048550 or 6045829 or 6007845 or 5922355 or 5916596 or 5874111 or 5858410 or 5849884 or 5833891 or 5766635 or 5716642 or 5665331 or 5662932 or 5662883 or 5660858 or 5641515 or 5587143 or 5580579 or 5578325 or 5573783 or 5569448 or 5565383 ).pn.

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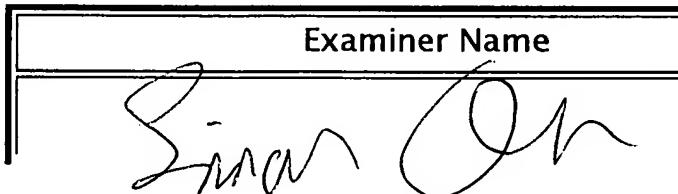
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INFORMATION DISCLOSURE CITATION  
IN AN APPLICATION  
(use several sheets if necessary)

PTO Form 1449

Atty Docket No. JFT-5657A-2	Application No. 10/021,692
Applicant James E. Kipp et al.	
Filing Date 12 December 2001	Group 1615

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Examiner: *Simon Al* Date Considered: *3/17/03*

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PTO Form 1449		Applicant James E. Kipp et al.	
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PATENT & TRADEMARK OFFICE

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						Yes	No
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Examiner: <i>Siniva</i>	Date Considered: <i>3/17/03</i>
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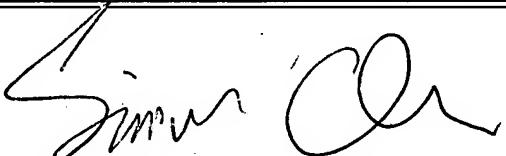


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P14	5346702	1994-09-13		Na et al.	424	490
P15	5340564	1994-08-23		Illig et al.	424	9
P16	5336507	1994-08-09		Na et al.	424	489
P17	5326552	1994-07-05		Na et al.	424	4
P18	5302401	1994-04-12		Liversidge et al.	424	501
P19	5298262	1994-03-29		Na et al.	424	489
P20	5250236	1993-10-05		Gasco	264	4.4
P21	5246707	1993-09-21		Haynes	424	450
P22	5188837	1993-02-23		Domb	424	450
P23	5152923	1992-10-06		Weder et al.	252	312
P24	5145684	1992-09-08		Liversidge et al.	424	489
P25	5133908	1992-07-28		Stainmesse et al.	264	4.1
P26	5100591	1992-03-31		Leclef et al.	264	4.6
P27	5091188	1992-02-25		Haynes	424	450
P28	5091187	1992-02-25		Haynes	424	450
P29	5078994	1992-01-07		Nair et al.	424	501
P30	5023271	1991-06-11		Vigne et al.	514	458
P31	4973465	1990-11-27		Baurain et al.	242	406

88	P32	4798846	1989-01-17		Glen et al.	514	713
	P33	4725442	1988-02-16		Haynes	424	490
	P34	4622219	1986-11-11		Haynes	424	38
	P35	4540602	1985-09-10		Motoyama et al.	427	213.31
	P36	4452817	1984-06-05		Glen et al.	424	346
	P37	4073943	1978-02-14		Wretlind et al.	424	358
	P38	4056635	1977-11-01		Glen et al.	424	346



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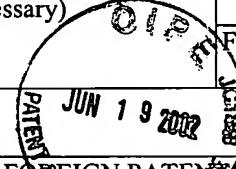
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Atty Docket No. JFT-5657A-2	Application No. 10/021,692
Applicant James E. Kipp et al.	
Filing Date 12 December 2001	Group 1615



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SJ.	EP 0808154 B1	20 Dec 2000	EP	A61K	9/107	X	
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